Search Notes			

Application/Control No.	Applicant(s)/Patent u Reexamination	nder
10/810,889	TANINO ET AL.	
Examiner	Art Unit	
Quang T. Van	3742	

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SEARCHED				
Class	Subclass	Date	Examiner	
219	64,216	6/22/05	Qv	
399	69,70	j		
	328-331			
	333,334			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
219	619	12/12/05	ar
399	69	12/12/05	ar
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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